## 2SJ350

### Silicon P-Channel MOS FET

# **HITACHI**

ADE-208-138

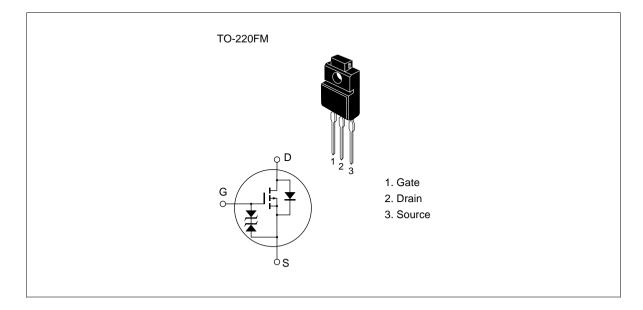
### **Application**

High speed power switching

#### **Features**

- Low on-resistance
- High speed switching
- Low drive current
- 4 V gate drive device can be driven from 5 V source
- Suitable for switching regulator, DC-DC converter

### **Outline**





## 2SJ350

## **Absolute Maximum Ratings** ( $Ta = 25^{\circ}C$ )

Item	Symbol	Ratings	Unit
Drain to source voltage	$V_{ t DSS}$	-120	V
Gate to source voltage	V <sub>GSS</sub>	±20	V
Drain current	I <sub>D</sub>	<b>–</b> 6	A
Drain peak current	I <sub>D(pulse)</sub> *1	-12	A
Body to drain diode reverse drain current	I <sub>DR</sub>	-6	A
Channel dissipation	Pch*2	20	W
Channel temperature	Tch	150	°C
Storage temperature	Tstg	-55 to +150	°C

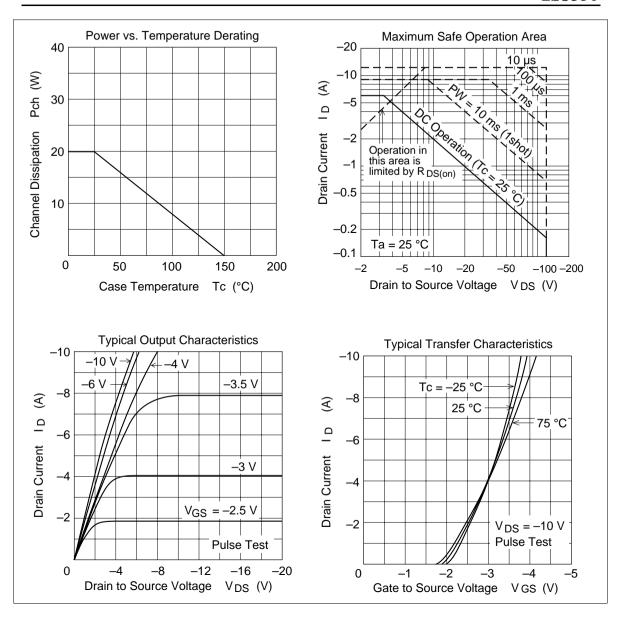
Notes: 1. PW  $\leq$  10  $\mu$ s, duty cycle  $\leq$  1%

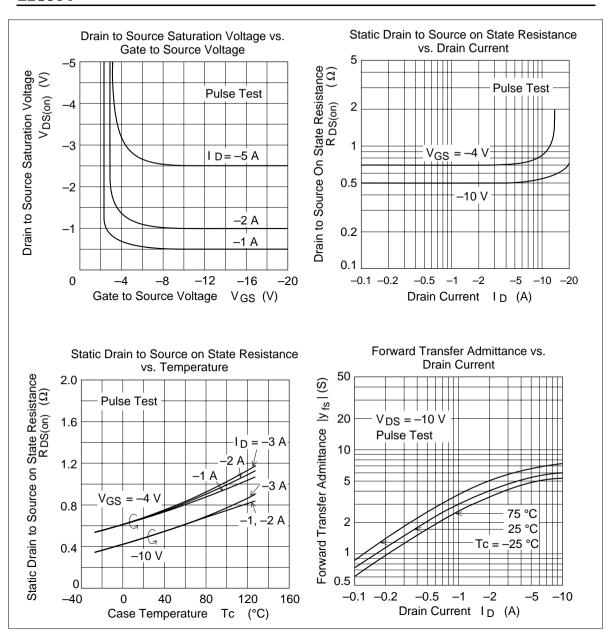
2. Value at  $T_c = 25^{\circ}C$ 

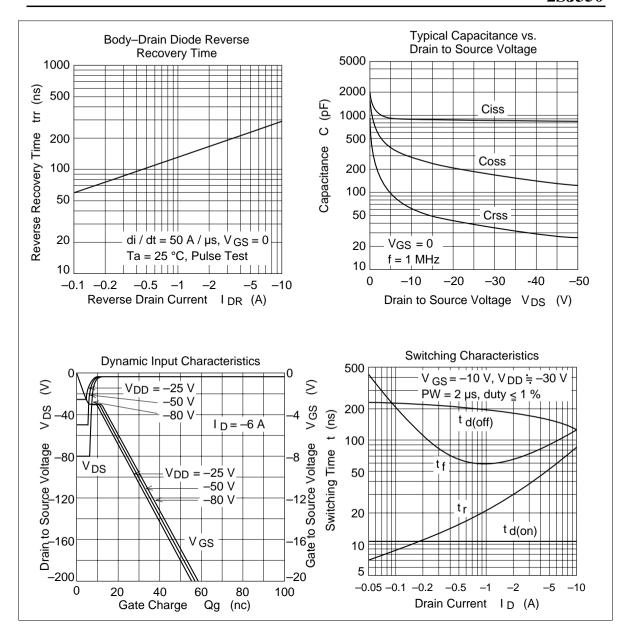
## **Electrical Characteristics** ( $Ta = 25^{\circ}C$ )

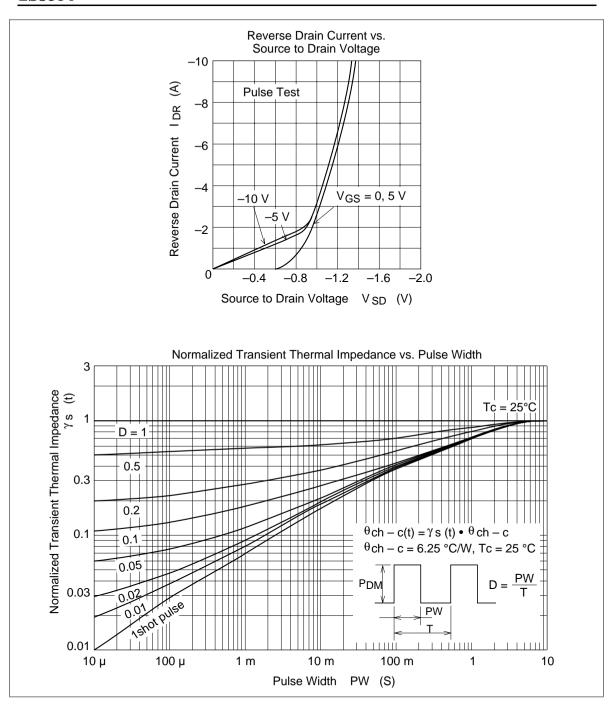
Item	Symbol	Min	Тур	Max	Unit	Test conditions
Drain to source breakdown voltage	$V_{(BR)DSS}$	-120	_	_	V	$I_{D} = -10 \text{ mA}, V_{GS} = 0$
Gate to source breakdown voltage	$V_{(BR)GSS}$	±20	_	_	V	$I_{G} = \pm 100 \ \mu A, \ V_{DS} = 0$
Gate to source leak current	I <sub>GSS</sub>	_	_	±10	μΑ	$V_{GS} = \pm 16 \text{ V}, V_{DS} = 0$
Zero gate voltage drain current	I <sub>DSS</sub>	_	_	-250	μΑ	$V_{DS} = -100 \text{ V}, V_{GS} = 0$
Gate to source cutoff voltage	$V_{\rm GS(off)}$	-1.0	_	-2.0	V	$I_{D} = -1 \text{ mA}, V_{DS} = -10 \text{ V}$
Static drain to source on state	R <sub>DS(on)</sub>		0.5	0.7	Ω	$I_D = -4 \text{ A}, V_{GS} = -10 \text{ V}^{*1}$
resistance		_	0.7	0.9	Ω	$I_D = -4 \text{ A}, V_{GS} = -4 \text{ V}^{*1}$
Forward transfer admittance	y <sub>fs</sub>	3.0	5.0	_	S	$I_D = -4 \text{ A}, V_{DS} = -10 \text{ V}^{*1}$
Input capacitance	Ciss	_	900	_	pF	$V_{DS} = -10 \text{ V}, V_{GS} = 0,$
Output capacitance	Coss	_	265	_	pF	f = 1 MHz
Reverse transfer capacitance	Crss	_	65	_	pF	
Turn-on delay time	$t_{\text{d(on)}}$	_	11	_	ns	$I_D = -4 A, V_{GS} = -10 V,$
Rise time	t <sub>r</sub>	_	45	_	ns	$R_L = 7.5 \Omega$
Turn-off delay time	t <sub>d(off)</sub>	_	170	_	ns	
Fall time	t <sub>f</sub>	_	80	_	ns	
Body to drain diode forward voltage	$V_{DF}$	_	-1.2	_	V	$I_F = -6 \text{ A}, V_{GS} = 0$
Body to drain diode reverse recovery time	t <sub>rr</sub>	_	240	_	ns	$I_F = -6 \text{ A}, V_{GS} = 0,$ $di_F/dt = 50 \text{ A}/\mu\text{s}$

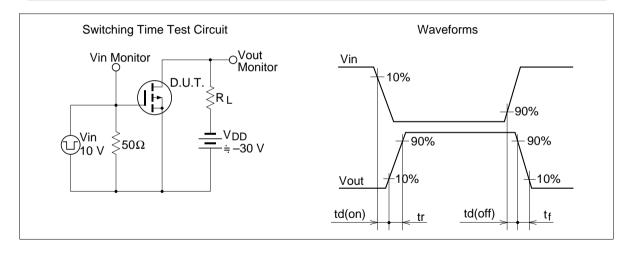
Note: 1. Pulse test

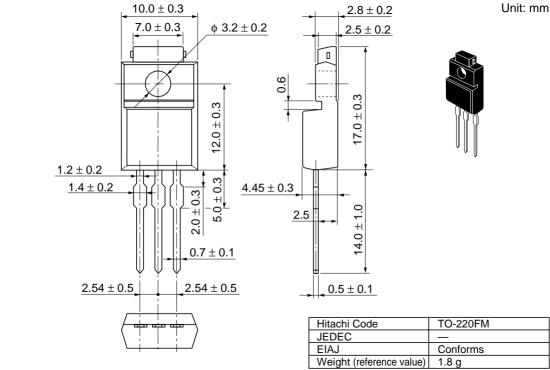












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